## Terahertz radiation induced by coherent phonon generation via impulsive stimulated Raman scattering in paratellurite

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We report on the observation of terahertz radiation in a noncentrosymmetric insulating oxide, paratellurite ( $\alpha$ -TeO<sub>2</sub>), by irradiation of a femtosecond laser pulse at room temperature. In the power spectrum of the terahertz radiation, an intensity fringe pattern with a period of ~0.25 THz shows up below 3 THz. It can be reproduced by taking into account the effective generation length for the terahertz radiation with a poor phase-matching condition. In addition, a temporal oscillation component appears in the radiated terahertz wave with a frequency of ~3.71 THz, which is in good agreement with the center frequency of the Raman active longitudinal optical *E* mode. On the basis of comprehensive polarized optical and Raman spectroscopic studies, we explain the generation mechanism of the temporal oscillation component in terms of the coherent phonon generation via impulsive stimulated Raman scattering.

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## I. INTRODUCTION

An ultrafast laser pulse, whose pulse width is shorter than the inverse of the frequency of the optical phonon mode, makes it possible to coherently drive optical phonons [1–3]. This process is termed *coherent phonon generation*. Interesting phenomena based on coherent phonon generation were previously reported by a variety of experiments [2,3], for example, ultrafast control of coherent phonons by using a pair of femtosecond laser pulses with an appropriate interval [4,5], the observation of vibronic wave packets in time domain [6], and the generation of the frequency comb over 100 THz [7]. Furthermore, it was demonstrated that narrow-band terahertz waves can be emitted by coherent phonon generation in various kinds of semiconductors such as Te [8,9], GaAs [10], GaAs/AlAs multiple quantum wells [11], (Pb,Cd)Te [12], InSb [13–15], and Li(In,Ga)(S,Se)<sub>2</sub> [16].

In these semiconductors, it was reported that the generated terahertz wave consists of a single-cycle terahertz pulse and a temporal oscillation component; the frequency of the latter corresponds to that of the optical phonon mode. So far, two mechanisms of terahertz radiation by coherent phonons have been proposed. One is the generation of coherent longitudinal optical (LO) phonons of infrared active modes [10]; the generated optical phonons modulate nonlinear polarization  $P_{\rm NL}$ , resulting in the emission of the terahertz wave at the phonon frequency. In optically opaque semiconductors such as Te and GaAs, the modulation of  $P_{\rm NL}$  is induced mainly by photogenerated carriers in the screening process [8,9,11–14]. Especially in the case of Te, it was confirmed that a narrow-band terahertz wave was due to the generation of the coherent phonon of the infrared active LO  $A_1$  mode [8]. The other proposed mechanism is the generation of the coherent LO phonons of the Raman active modes via impulsive stimulated Raman scattering (ISRS) [17]. In InSb [15] and Li(In,Ga)(S,Se)<sub>2</sub> [16], ISRS was proposed to explain the observed oscillation components in the radiated terahertz waves. However, the role of the ISRS mechanism in terahertz radiation has not been clarified yet. In the optically opaque semiconductors such as InSb,  $P_{\rm NL}$  would be modulated by the screening process of the photogenerated carriers. Thus,

it is difficult to isolate the contribution of ISRS to the measured terahertz radiation. Furthermore, an infrared active mode usually appears at nearly the same frequency of the Raman active mode in noncentrosymmetric media. Thus, the comprehensive optical and Raman spectroscopic studies with high frequency resolution are necessary to identify the terahertz radiation mechanism as coherent phonon generation by ISRS.

 $\alpha$ -TeO<sub>2</sub> is an ideal compound to scrutinize the role of ISRS for the terahertz radiation. In contrast to the optically opaque semiconductors such as Te and InSb,  $\alpha$ -TeO<sub>2</sub> is an insulator with a transparent window from 0.33 to 6.5  $\mu$ m [18,19]. Thus, no photo-carriers are generated by the irradiation of femtosecond laser pulses with a wavelength of 800 nm used in this work. Crystal structure of  $\alpha$ -TeO<sub>2</sub> is tetragonal with the point group of  $D_4$  (422) [20]. Figure 1(a) shows the schematic illustration of the crystal structure [21].  $\alpha$ -TeO<sub>2</sub> contains four TeO<sub>2</sub> molecules in the unit cell, as guided by the dotted lines. We also illustrate the crystal view of (110) and (101) planes in Figs. 1(b) and 1(c), respectively. At room temperature,  $\alpha$ -TeO<sub>2</sub> lacks the space inversion symmetry, resulting in the piezoelectricity [22]. Due to the large acoustic-optic effect  $[22,23], \alpha$ -TeO<sub>2</sub> is used as a constitutive element for the optical modulation and deflection devices in the visible frequency region. Furthermore, it was reported that the second-order nonlinear optical coefficient of  $\alpha$ -TeO<sub>2</sub> has a large value in the transparent frequency region, e.g., 0.59 pm/V [24] or  $0.69 \pm 0.08$  pm/V at 1.064  $\mu$ m [25]. However, terahertz radiation in  $\alpha$ -TeO<sub>2</sub> has never been reported so far.

In this paper, we report on the observation of the terahertz radiation in  $\alpha$ -TeO<sub>2</sub> by the irradiation of a femtosecond laser pulse at room temperature. In the power spectrum of terahertz radiation, an intensity fringe pattern appeared below 3 THz with a period of ~0.25 THz. In addition, we observed a temporal oscillation component with a frequency of ~3.71 THz in the radiated terahertz wave. The frequency of this component just corresponds to the center frequency of a Raman active  $E_{\rm LO}$  mode. On the basis of the systematic investigation of polarized optical and Raman spectroscopies in the terahertz frequency region, we concluded that the

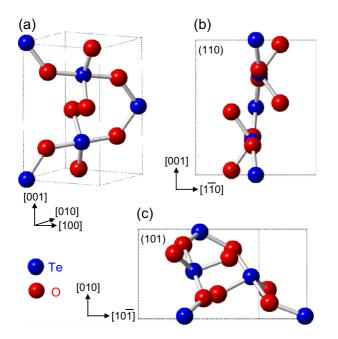


FIG. 1. (Color online) Schematic illustrations of the crystal structure of  $\alpha$ -TeO<sub>2</sub> [21]. (a) Overview of the crystal structure. Crystal views of (b) the (110) plane and (c) the (101) plane. The dotted lines indicate the unit cell.

observed temporal oscillation component in the radiated terahertz wave is due to the coherent phonon generation via ISRS.

The format of this article is as follows. In Sec. II, we briefly describe the general expression of the second-order nonlinear optical susceptibility in  $\alpha$ -TeO<sub>2</sub> and examine the optical rectification for the terahertz radiation. We detail the experimental setups in Sec. III. Section IV is devoted to showing the experimental results. After the detailed descriptions of the results of the polarized optical spectroscopy in the visible and terahertz frequency regions (Sec. IV A) and the polarized Raman spectroscopy (Sec. IV B), we provide the basic features of terahertz radiation in  $\alpha$ -TeO<sub>2</sub> in Sec. IV C and show the results of its azimuth-angle and laser-power dependencies in Sec. IV D. In Sec. V, we discuss the radiation mechanism of the single-cycle terahertz pulse at 0 ps in terms of the optical rectification (Sec. VA), the origins of the intensity fringe pattern in the power spectrum of terahertz radiation (Sec. VB), the second pulse at around 3.5 ps (Sec. VC), and the temporal oscillation component with a frequency of  $\sim$ 3.71 THz (Sec. VD). A summary is given in Sec. VI.

## II. SECOND-ORDER NONLINEAR OPTICAL SUSCEPTIBILITY TENSOR

When a noncentrosymmetric medium is irradiated with a femtosecond laser pulse, a transient nonlinear polarization  $P_{\rm NL}$  is induced in the subpicosecond time scale. This results in the emission of terahertz waves into free space. Such an optical rectification has been widely recognized as the dominant process of terahertz radiation in various noncentrosymmetric media such as ZnTe [26]. In the case of  $\alpha$ -TeO<sub>2</sub>, the nonzero components of the second-order nonlinear optical susceptibility tensor are  $\chi_{yzx}^{(2)} = -\chi_{xyz}^{(2)} = -\chi_{xyz}^{(2)} = -\chi_{xzy}^{(2)}$  [25,27,28]. Then

 $P_{\rm NL}$  using the contradicted d tensor is given by

$$P_{\rm NL} = \epsilon_0 \begin{bmatrix} 0 & 0 & 0 & d_{14} & 0 & 0 \\ 0 & 0 & 0 & 0 & -d_{14} & 0 \\ 0 & 0 & 0 & 0 & 0 & 0 \end{bmatrix} \begin{bmatrix} E_x^2 \\ E_y^2 \\ E_z^2 \\ 2E_y E_z \\ 2E_z E_x \\ 2E_z E_y \end{bmatrix}.$$
(1)

Here  $\epsilon_0$  is the vacuum permittivity.  $E_x$ ,  $E_y$ , and  $E_z$  represent the x, y, and z components of the electric field of a femtosecond laser pulse, respectively. We used the laboratory coordinate as the X (horizontal) axis and the Y (vertical) axis [see Fig. 5(a)]. The angle  $\theta$  was defined as the angle of the [010] direction of the crystal relative to the X axis. When the electric field  $E_0$  of a femtosecond laser pulse is set parallel to the X axis  $(E_0 \parallel X)$ ,  $P_{\rm NL}$  of a (101)-oriented single crystal as a function of  $\theta$  is given by

$$P_{\rm NL} = \begin{bmatrix} P_{10\overline{1}} \\ P_{010} \\ P_{101} \end{bmatrix} = \epsilon_0 d_{14} E_0^2 \begin{bmatrix} -\sqrt{2}\sin\theta\cos\theta \\ \sin^2\theta \\ 0 \end{bmatrix}.$$
(2)

On the other hand, in the  $E_0 \parallel Y$  configuration,  $P_{\text{NL}}$  as a function of  $\theta$  is given by

$$P_{\rm NL} = \begin{bmatrix} P_{10\bar{1}} \\ P_{010} \\ P_{101} \end{bmatrix} = \epsilon_0 d_{14} E_0^2 \begin{bmatrix} \sqrt{2} \sin\theta \cos\theta \\ \cos^2\theta \\ 0 \end{bmatrix}.$$
(3)

#### **III. EXPERIMENTAL PROCEDURES**

We used commercially available 0.5-mm-thick (110)oriented  $\alpha$ -TeO<sub>2</sub> single crystals to measure the optical spectra for extraordinary ray ( $E^{\omega} \parallel [001]$ ) and ordinary ray ( $E^{\omega} \parallel$  $[1\overline{1}0]$ ), respectively. In the terahertz frequency region, we measured the reflectance and transmittance spectra by using Fourier-transformed infrared (FT-IR) spectroscopy and terahertz time-domain spectroscopy, respectively. The frequency range covered by the FT-IR spectrometer was  $40-700 \text{ cm}^{-1}$ . In the terahertz time-domain spectroscopy, we used a modelocked Ti:Al<sub>2</sub>O<sub>3</sub> laser (the center wavelength of 800 nm, the repetition rate of 80 MHz, and the pulse width of 100 fs). Terahertz emitter was a 0.5-mm thick (110)-oriented ZnTe single crystal. The terahertz wave passing through the sample was detected by a low-temperature-grown GaAs (LT-GaAs) detector. For the measurements of the reflectance and transmittance in the energy range of 0.5-5 eV, we used the grating monochromator equipped with an optical microscope.

For the polarized Raman scattering experiments, commercially available 0.5-mm-thick (110)- and (101)-oriented  $\alpha$ -TeO<sub>2</sub> single crystals were used. The sample was excited by a continuous-wave He-Ne laser [632 nm (1.96 eV)]. The scattering light was analyzed by a triple-grating monochromator and detected by use of a CCD camera in the backscattering geometry.

The terahertz radiation experiments were carried out on a (101)-oriented  $\alpha$ -TeO<sub>2</sub> single crystal in a dried air box to

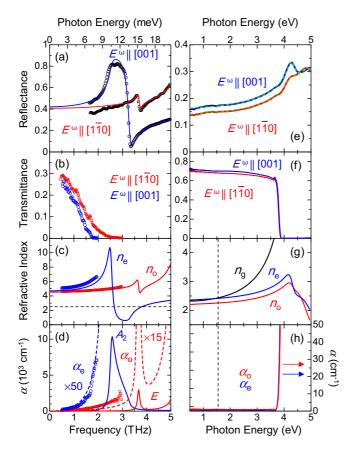


FIG. 2. (Color online) Polarized optical spectra of a (110)oriented single crystal of  $\alpha$ -TeO<sub>2</sub> in the terahertz, visible, and ultraviolet frequency regions. (a) Reflectance R spectra in the  $E^{\omega} \parallel$ [001] (circles) and  $E^{\omega} \parallel [1\overline{10}]$  (squares) configurations, measured by Fourier-transformed infrared (FT-IR) spectroscopy. The solid lines are results of least-squares fit to the R spectra with fitting parameters listed in Table III in Appendix B. Transmittance T spectra in the  $E^{\omega} \parallel [001]$  (circles) and  $E^{\omega} \parallel [110]$  (squares) configurations, measured by terahertz time-domain spectroscopy. (c) Refractive index *n* and (d) absorption coefficient  $\alpha$  spectra for the ordinary ray (red) and for the extraordinary ray (blue). n and  $\alpha$  indicated by symbols and lines were determined by terahertz time-domain spectroscopy and the dispersion analysis of the R spectra, respectively. The horizontal broken line in (c) indicates the value of the group refractive index at 800 nm. (e) R and (f) T spectra in the  $E^{\omega} \parallel [001]$  (blue lines) and  $E^{\omega} \parallel [1\overline{1}0]$  (red lines) configurations in 0.5–5 eV, measured by grating spectroscopy. The broken lines in (e) indicate the fitting results of the dispersion analysis with parameters listed in Table I. (g) n and (h)  $\alpha$  spectra for the ordinary ray (red line) and for the extraordinary ray (blue line). The black line in (g) represents the group refractive index  $n_g$  spectrum. The vertical broken lines in (g) and (h) indicate the photon energy of the femtosecond laser (1.55 eV) used for the terahertz radiation experiments.

eliminate the absorption of the terahertz waves by water vapor. We adopted standard photoconducting sampling technique with a LT-GaAs detector [26]. A beam from the mode-locked Ti:Al<sub>2</sub>O<sub>3</sub> laser was focused on the sample in normal incidence with a beam spot diameter of ~25  $\mu$ m. Unless otherwise stated, the laser power was fixed to be 30 mW (~150  $\mu$ J/cm<sup>2</sup> per pulse). We directly measured the waveform of the terahertz

electric field by monitoring the photocurrent of the LT-GaAs detector. A wire grid polarizer was inserted in front of the LT-GaAs detector. The additional details of experimental procedures will be described in Secs. IV C and IV D.

All the experiments were performed at room temperature.

#### **IV. RESULTS**

#### A. Polarized optical spectra

Figure 2(e) shows the polarized reflectance R spectra in 0.5–5 eV. R spectra in the  $E^{\omega} \parallel [001]$  (blue line) and  $E^{\omega} \parallel [1\overline{1}0]$  (red line) configurations were obtained using a (110)-oriented single crystal. We also show in Fig. 2(f) the polarized transmittance T spectra in these configurations. The steep decrease in T and the gradual increase in R above 3.7 eVare due to the presence of the interband transition from the O 2p state to the Te 5s state at  $\sim$ 4 eV [19,29,30]. In the  $E^{\omega} \parallel [001]$  configuration, a peak structure at 4.28 eV is seen in the R spectrum. On the other hand, a peak structure at 4.81 eV with a shoulder structure at 4.26 eV is discerned in the  $E^{\omega} \parallel [1\overline{10}]$  configuration. These structures were previously reported in Ref. [29] and assigned to band-edge excitons. In order to obtain the refractive index spectra, we performed the dispersion analysis of the measured R spectra; we assumed that R spectrum is composed of Lorentz oscillators. The fitting results by assuming Lorentz oscillators with the damping rate  $\gamma_i$  and the oscillator strength  $f_i$  are shown by the green broken lines in Fig. 2(e); the measured R spectra were reproduced with parameters listed in Table I. With the use of the obtained fitting parameters, we calculated the refractive index spectra for the ordinary ray  $n_0$  and the extraordinary ray  $n_e$  in the visible to ultraviolet frequency regions, which are shown by red and blue lines in Fig. 2(g), respectively. There is refractive index anisotropy in the transparent frequency region below 3.6 eV; the birefringence is  $\sim 0.16$  at 800 nm. The obtained  $n_0$ and  $n_{\rm e}$  spectra are consistent with those previously reported in the transparent frequency region (1.2-3.1 eV) [19]. We also evaluated the group refractive index  $n_{\rm g}$  spectrum for  $[10\overline{1}]$ -polarized light with the use of the parameters extracted from the dispersion analysis of the R spectrum.  $n_g$  is given by  $|n - \lambda \frac{dn}{d\lambda}|$ , where  $\lambda$  is the wavelength and  $n = (n_0 + n_e)/2$ . The calculated  $n_g$  spectrum is shown by the black line in Fig. 2(g);  $n_g$  at 800 nm [the wavelength of the femtosecond laser used in the terahertz radiation experiments (the vertical broken line)] was estimated to be  $\sim 2.52$ . As seen in the absorption coefficient  $\alpha$  spectra [Fig. 2(h)], which were obtained by the relationship of  $\alpha = -\frac{1}{d} \ln(\frac{T}{(1-R)^2})$  with the thickness d of the sample (0.5 mm),  $\alpha$ -TeO<sub>2</sub> has a transparent

TABLE I. Obtained fitting parameters of  $\alpha$ -TeO<sub>2</sub> in the  $E^{\omega} \parallel$  [001] configuration with the high frequency dielectric constant  $\epsilon_{\infty} = 3.47$  and the  $E^{\omega} \parallel$  [110] configuration with  $\epsilon_{\infty} = 3.42$ .

Mode <i>i</i>	Configuration	$\omega_i (eV)$	$\gamma_i (eV)$	$f_i$
1	$E^{\omega} \parallel [001]$	4.274	0.344	0.374
2		4.851	1.308	1.767
3	$E^{\omega} \parallel [1\overline{1}0]$	4.291	0.345	0.159
4		4.701	0.919	1.336

window below 3.6 eV [19], i.e.,  $\alpha$  at 800 nm for extraordinary and ordinary rays are negligibly small (~1 cm<sup>-1</sup>).

Figure 2(b) shows the polarized T spectra in the  $E^{\omega} \parallel [001]$ (circles) and  $E^{\omega} \parallel [1\overline{1}0]$  (squares) configurations, measured by terahertz time-domain spectroscopy. Due to the presence of the strong absorptions, we only yielded the T spectra below ~2.0 THz in the  $E^{\omega} \parallel [001]$  configuration and below  $\sim$ 3.0 THz in the  $E^{\omega} \parallel [1\overline{10}]$  configuration. From the measured T spectra, we derived the  $\alpha$  and n spectra; the details of the derivation procedure are described in Appendix A. The  $\alpha_0$  and  $\alpha_e$  spectra are denoted by squares and circles in Fig. 2(d), respectively. We also show in Fig. 2(c) the  $n_0$ and  $n_{\rm e}$  spectra, which are represented by squares and circles, respectively. To obtain the optical spectra above 2.0 THz, we used the polarized R spectra measured in the  $E^{\omega} \parallel [001]$ and  $E^{\omega} \parallel [1\overline{10}]$  configurations, which are shown by open circles and squares in Fig. 2(a), respectively. In the  $E^{\omega} \parallel [1\overline{1}0]$ configuration, a reflection peak is discerned at around 3.7 THz. On the other hand, a pronounced dispersion appears at around 3 THz in the  $E^{\omega} \parallel [001]$  configuration. We performed the dispersion analysis to extract complex optical constants. In this analysis, we used the polarized R spectra in the frequency range of 1.9–24 THz [see Fig. 10(a)]; the analysis is detailed in Appendix B. The solid lines in Fig. 2(a) are the calculated R spectra obtained by the dispersion analysis, which well reproduce the measured R spectra. The n and  $\alpha$  spectra are also calculated and shown by solid lines in Figs. 2(c) and 2(d), respectively. The calculated *n* and  $\alpha$  (the broken lines) are in good agreement with those (symbols) obtained by the terahertz time-domain spectroscopy. This ensures the validity of the dispersion analysis used here. As can be seen, there is a strong anisotropy in the terahertz frequency region. A peak is discerned at 3.66 THz in the  $\alpha_0$  spectrum. Accordingly, a dispersive structure emerges in the  $n_0$  spectrum. On the other hand,  $n_e$  and  $\alpha_e$  show a more pronounced dispersion and a peak structure at 2.58 THz, respectively. The observed results are in good agreement with those previously reported in Ref. [31].

According to the factor group analysis of  $\alpha$ -TeO<sub>2</sub>, the representations of the optical phonons (excluding the acoustic phonons) at zone center are  $4A_1 + 4A_2 + 5B_1 + 4B_2 + 8E$  [31,32]. We listed the polarization selection rules of the phonon modes in the terahertz frequency region in Table II.  $A_2$  modes are Raman inactive and infrared active only for the extraordinary ray. On the contrary, *E* modes are Raman and

infrared active for the ordinary ray. Thus, the peak structures at 2.58 THz in the  $\alpha_e$  spectrum and at 3.66 THz in the  $\alpha_o$  spectrum can be assigned to the  $A_2$  and E modes, respectively.

## **B.** Polarized Raman spectra

So far, several results have been reported on the polarized Raman spectra of  $\alpha$ -TeO<sub>2</sub> in the terahertz frequency region [32–35]. However, the mode assignment was controversial. For example, several forbidden Raman modes, which cannot be explained by the leakage of the polarization due to the misorientation of the crystal, show up when a (001)-oriented single crystal was used (Ref. [32]). The "anomalous polarization-selection-rule violations" make it difficult to precisely perform the assignment of the observed Raman modes. Very recently, Raman and hyper-Raman scattering experiments using (110)-oriented single crystals were conducted to exclude the effect of the optical activity of  $\alpha$ -TeO<sub>2</sub> in the transparent frequency region [35]. The revised interpretation of the Raman modes was straightforward in terms of the crystal symmetry.

Before the detailed discussion of the results, we describe the selection rule of Raman scattering of  $\alpha$ -TeO<sub>2</sub>. Raman tensors of the point group of  $D_4$  (422) in the coordinate, in which the *x*, *y*, and *z* axes are parallel to the [100], [010], and [001] directions of the crystal, respectively, are given by

$$A_{1} = \begin{pmatrix} a & 0 & 0 \\ 0 & a & 0 \\ 0 & 0 & b \end{pmatrix}, B_{1} = \begin{pmatrix} c & 0 & 0 \\ 0 & -c & 0 \\ 0 & 0 & 0 \end{pmatrix},$$
$$B_{2} = \begin{pmatrix} 0 & d & 0 \\ d & 0 & 0 \\ 0 & 0 & 0 \end{pmatrix}, E_{x} = \begin{pmatrix} 0 & 0 & 0 \\ 0 & 0 & e \\ 0 & e & 0 \end{pmatrix},$$
$$E_{y} = \begin{pmatrix} 0 & 0 & -e \\ 0 & 0 & 0 \\ -e & 0 & 0 \end{pmatrix},$$
(4)

where *a*, *b*, *c*, *d*, and *e* are the constant [32]. Our Raman scattering experiments were conducted on (110)- and (101)- oriented single crystals, so we defined new coordinates as x', y', and z' axes for experiments using a (110)-oriented crystal and as x'', y'', and z'' axes for experiments using a (101)- oriented crystal. In the new coordinate, in which the x', y', and

TABLE II. Selection rules of infrared and Raman modes and the summary of the mode assignment of  $\alpha$ -TeO<sub>2</sub> in the terahertz frequency region.

Selection Rule	Configurations	Representations	$A_1$ (THz)	$A_2$ (THz)	$B_1$ (THz)	$B_2$ (THz)	$E_{\rm TO}~({\rm THz})$	$E_{\rm LO}~({\rm THz})$
Raman	$x'(z'z')\overline{x'}$	$A_1$	4.46		_			
	$x'(y'y')\overline{x'}$	$A_1 + B_2$	4.49	_	_	4.65	_	_
	$x'(y'z')\overline{x'}$	$E_{ m LO}$	_	_	—		—	3.71, 5.92
	$x''(z''z'')\overline{x''}$	$A_1 + B_1 + E_{\text{TO}}$	4.48	_	1.88		3.67, 5.26	—
	$x''(y''y'')\overline{x''}$	$A_1 + B_1$	4.48	_	1.88, 3.77, 5.32, 6.33		—	-
Infrared	$E^{\omega} \parallel [001]$	$A_2$	—	2.58	—		—	—
	$E^{\omega} \parallel [1\overline{1}0]$	$E_{\rm TO}$ / $E_{\rm LO}$	—	_			3.66, 5.37, 6.48	3.71, 5.90, 7.09 <sup>a</sup>
Terahertz								
Radiation	$E^{\omega} \parallel [010]$	Unknown	—			—		3.71

 $^{a}E_{LO}$  was determined by the peak position of the loss-function spectrum shown in Fig. 8(a).

z' axes are parallel to the [110], [110], and [001] directions of the crystal, respectively, Raman tensors in Eq. (4) are converted to

$$A_{1}' = \begin{pmatrix} a & 0 & 0 \\ 0 & a & 0 \\ 0 & 0 & b \end{pmatrix}, B_{1}' = \begin{pmatrix} 0 & -c & 0 \\ -c & 0 & 0 \\ 0 & 0 & 0 \end{pmatrix},$$
$$B_{2}' = \begin{pmatrix} d & 0 & 0 \\ 0 & -d & 0 \\ 0 & 0 & 0 \end{pmatrix}, E_{x}' = \frac{1}{\sqrt{2}} \begin{pmatrix} 0 & 0 & e \\ 0 & 0 & e \\ e & e & 0 \end{pmatrix},$$
$$E_{y}' = \frac{1}{\sqrt{2}} \begin{pmatrix} 0 & 0 & -e \\ 0 & 0 & e \\ -e & e & 0 \end{pmatrix}.$$
(5)

In another new coordinate, in which the x'', y'', and z'' axes are parallel to the [101], [010], and  $[10\overline{1}]$  directions of the crystal, respectively, Raman tensors in Eq. (4) are converted to

$$A_{1}^{"} = \frac{1}{2} \begin{pmatrix} a+b & 0 & -a+b \\ 0 & 2a & 0 \\ -a+b & 0 & a+b \end{pmatrix},$$

$$B_{1}^{"} = \frac{1}{2} \begin{pmatrix} c & 0 & -c \\ 0 & -2c & 0 \\ -c & 0 & c \end{pmatrix}, B_{2}^{"} = \frac{1}{\sqrt{2}} \begin{pmatrix} 0 & d & 0 \\ d & 0 & -d \\ 0 & -d & 0 \end{pmatrix},$$

$$E_{x}^{"} = \frac{1}{\sqrt{2}} \begin{pmatrix} 0 & e & 0 \\ e & 0 & e \\ 0 & e & 0 \end{pmatrix}, E_{y}^{"} = \frac{1}{\sqrt{2}} \begin{pmatrix} -e & 0 & 0 \\ 0 & 0 & 0 \\ 0 & 0 & e \end{pmatrix}.$$
(6)

We listed in Table II the selection rule of the Raman tensors given by Eqs. (5) and (6).

Figures 3(a) to 3(f) show the polarized Raman spectra in various configurations in the frequency region of 1.5-7 THz. The frequency resolution was  $\sim 2 \text{ cm}^{-1}$ , as indicated by a pair of vertical lines. In the Raman spectrum in the  $x'(z'z')\overline{x'}$ configuration [Fig. 3(a)], we observe a peak structure at  $\sim$ 4.46 THz. According to the selection rule of Raman modes listed in Table II, only  $A_1$  mode is active in this configuration. Thus, the observed mode can be assigned to the  $A_1$  mode. The tiny peak structure at  $\sim$ 3.71 THz, indicated by an asterisk, is due to the leakage of the Raman mode discerned in the  $x'(y'z')\overline{x'}$  configuration [Fig. 3(b)]. In the  $x'(y'z')\overline{x'}$ configuration, only the longitudinal optical  $E(E_{LO})$  mode is active (see Table II) and thus the peak structures at  $\sim$ 3.71 THz and  $\sim 5.92$  THz are assigned to the  $E_{\rm LO}$  modes. The tiny peak structure at  $\sim 4.46$  THz (indicated by an asterisk) arises from the leakage of the  $A_1$  mode observed in the  $x'(z'z')\overline{x'}$  configuration [Fig. 3(a)]. In the  $x'(y'+z'y'+z')\overline{x'}$ configuration [Fig. 3(c)], two peak structures are observed at  $\sim$ 3.71 THz and  $\sim$ 5.92 THz, which can be assigned to the  $E_{\rm LO}$  modes by comparing them with the Raman spectrum in the  $x'(y'z')\overline{x'}$  configuration [Fig. 3(b)]. In addition to two  $E_{\rm LO}$  modes, the peak structures at ~4.49 THz and  $\sim$ 4.65 THz are discerned. Such peak structures are more pronounced in the  $x'(y'y')\overline{x'}$  configuration [Fig. 3(d)]. In this configuration, the  $A_1$  and  $B_2$  modes are active (see Table II). Within the frequency resolution, the center frequency of the

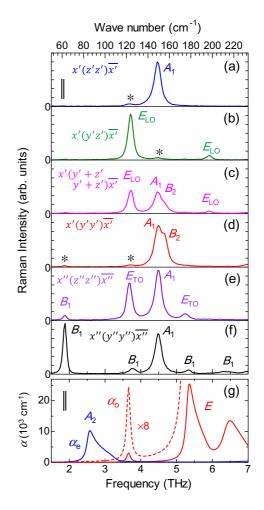


FIG. 3. (Color online) Polarized Raman and optical spectra of  $\alpha$ -TeO<sub>2</sub> in the terahertz frequency region. [(a)–(f)] Raman spectra in various configurations indicated in the upper part of each spectrum. Asterisks represent the leakage of the polarization. (g) Absorption coefficient  $\alpha$  spectra for ordinary and extraordinary rays. A pair of vertical lines in (a) and (g) indicate the frequency resolution.

observed mode (~4.49 THz) in the  $x'(y'y')\overline{x'}$  configuration corresponds to that of the  $A_1$  mode (~4.46 THz) in the  $x'(z'z')\overline{x'}$  configuration [Fig. 3(a)]. Thus, the peak structures at ~4.49 THz and ~4.65 THz in the  $x'(y'y')\overline{x'}$  configuration would be assigned to the  $A_1$  and  $B_2$  modes, respectively.

To confirm the mode assignment described above, we measured Raman spectra rotating the (110)-oriented single crystal by the angle  $\varphi$ , as illustrated in the inset of Fig. 4(a). We defined the laboratory coordinates as the X (horizontal) axis and the Y (vertical) axis.  $\varphi$  was defined as the angle of the [110] direction of the crystal relative to the X axis. Figures 4(a) and 4(b) show the  $\varphi$  dependence of the integrated Raman scattering intensity (circles) in the frequency region of 1.5–7 THz in the  $E_i \parallel E_s$  and  $E_i \perp E_s$  configurations, respectively.  $E_i$  and  $E_s$  represent the electric field of the incident and scattering light, respectively.  $E_s$  was set parallel to the X axis. The integrated Raman intensity depends on  $\varphi$ . According to Raman tensors given in Eq. (5), the integrated Raman intensity

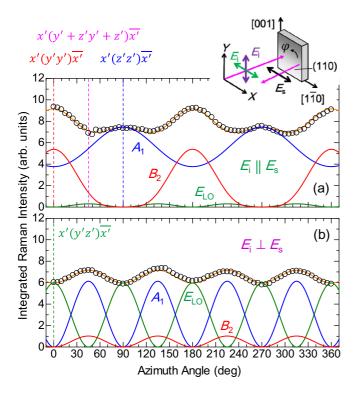


FIG. 4. (Color online) Raman scattering characteristics of  $\alpha$ -TeO<sub>2</sub>. Azimuth angle  $\varphi$  dependence of the integrated Raman scattering intensity (circles) in the frequency region 1.5–7 THz in the (a)  $E_i \parallel E_s$  and (b)  $E_i \perp E_s$  configurations. Inset of (a) shows the schematic illustration of the experimental geometry using a (110)-oriented single crystal.  $E_i$  and  $E_s$  indicate the electric field of the incident and detected light, respectively. Orange lines are obtained from the selection rule given in Eqs. (7) and (8).  $A_1$ ,  $B_2$ , and  $E_{LO}$  components are indicated by blue, red, and green lines, respectively.

*I* in the 
$$E_i \parallel E_s$$
 configuration can be expressed as  

$$I_{\parallel} = (a\cos^2\varphi + b\sin^2\varphi)^2 + d^2\cos^4\varphi + 4e^2\cos^2\varphi\sin^2\varphi,$$
(7)

where  $\varphi = 0^\circ$ ,  $\varphi = 45^\circ$ , and  $\varphi = 90^\circ$  correspond to the  $x'(y'y')\overline{x'}$ ,  $x'(y' + z'y' + z')\overline{x'}$ , and  $x'(z'z')\overline{x'}$  configurations, respectively. On the other hand, *I* in the  $E_i \perp E_s$  configuration can be expressed as

$$I_{\perp} = (-a+b)^{2} \cos^{2} \varphi \sin^{2} \varphi + d^{2} \cos^{2} \varphi \sin^{2} \varphi + e^{2} (\cos \varphi^{2} - \sin \varphi^{2})^{2}, \quad (8)$$

where  $\varphi = 0^{\circ}$  corresponds to the  $x'(y'z')\overline{x'}$  configuration. The fitting results using Eqs. (7) and (8) are shown by orange lines in Figs. 4(a) and 4(b), respectively. The observed  $\varphi$  dependencies can be well reproduced by adjusting the Raman tensors of *a*, *b*, *d*, and *e*. Blue, red, and green lines indicate the estimated  $\varphi$  dependence of the  $A_1$ ,  $B_2$ , and  $E_{\text{LO}}$ modes, respectively. Thus, we can conclude that the two peak structures at ~4.49 THz and ~4.65 THz in the  $x'(y'y')\overline{x'}$ configuration [Fig. 3(d)] are due to the  $A_1$  and  $B_2$  modes, respectively.

In the  $x''(z''z'')\overline{x''}$  configuration [Fig. 3(e)], four peak structures emerge at ~1.88 THz, ~3.67 THz, ~4.48 THz, and ~5.26 THz, which are assigned to the  $B_1$ , transverse optical

*E* ( $E_{TO}$ ),  $A_1$ , and  $E_{TO}$  modes, respectively (see Table II). In the  $x''(y''y'')\overline{x''}$  configuration [Fig. 3(f)], the  $B_1$  modes are more pronounced, while the  $E_{TO}$  mode disappears. Our mode assignments based on the polarized Raman scattering experiments using (110)- and (101)-oriented single crystals are consistent with the mode assignments reported in Refs. [32] and [35]. It should be noted that the frequencies of the Raman active  $E_{TO}$  modes nearly coincide with the frequencies of the peak structures (3.66 and 5.37 THz) in the  $\alpha_0$  spectrum shown in Fig. 3(g). A detailed discussion about this is given in Sec. V D.

#### C. Terahertz radiation

Figure 5(a) illustrates the experimental setup for terahertz radiation. In this experiment, the [010] direction of a (101)oriented crystal was set parallel to the X axis. The electric field of a femtosecond laser pulse was set parallel to the Y axis. By using the wire-grid polarizer in front of the LT-GaAs detector, we detected the terahertz electric field  $E_{THz}$  polarized along the X axis, i.e.,  $E_{\text{THz}} \parallel X$ . The penetration depth at 800 nm (the wavelength of a femtosecond laser pulse used here) was estimated to be  $\sim 6 \text{ mm}$  [see the  $\alpha$  spectrum in Fig. 2(h)], which exceeds the thickness of the sample (0.5 mm). Thus,  $\alpha$ -TeO<sub>2</sub> is transparent with respect to the incident femtosecond laser pulse. By the irradiation of a femtosecond laser pulse, we found terahertz radiation from (101)-oriented  $\alpha$ -TeO<sub>2</sub>. The measured waveform is shown in Fig. 5(b); a single-cycle pulse with a pulse width of  $\sim 0.3$  ps is observed at around 0 ps. After the single-cycle pulse, the temporal oscillation component with a period of  $\sim 0.27$  ps is discerned up to  $\sim 3$  ps. At around 3.5 ps, a second pulse shows up and the temporal oscillation component is also observed up to  $\sim 8$  ps. To see the spectrum of the terahertz radiation, we performed the Fourier transformation of the measured waveform. The frequency resolution was estimated to be 0.01 THz, which was determined by the measured time window  $\sim 100$  ps. The obtained power spectrum of the terahertz radiation is shown in Fig. 5(c). Below 3 THz, a fringe pattern is discerned with a period of  $\sim 0.25$  THz. Furthermore, a sharp peak appears at  $\sim$ 3.71 THz with a full-width at the half maximum of  $\sim 0.1$  THz. It should be noted that the sensitivity of our detection system has the maximum at  $\sim 1.6$ THz and decreases from  $\sim 1$  at 1.6 THz to  $\sim 0.07$  at 3.71 THz. This indicates that the actual generation efficiency of the terahertz radiation at 3.71 THz is larger than that below 3 THz by a factor of  $\sim 10$  as discussed in Sec. V B. The 3.71-THz peak corresponds to the oscillation with a period of  $\sim 0.27$  ps in Fig. 5(b). We discuss the origins of the single-cycle terahertz pulse at 0 ps in terms of the optical rectification in Sec. V A, the intensity fringe pattern with a period of  $\sim 0.25$  THz in Sec. V B, the second pulse at around 3.5 ps in Sec. V C, and the temporal oscillation component with a frequency of 3.71 THz in Sec. V D.

To estimate the efficiency of the terahertz radiation from  $\alpha$ -TeO<sub>2</sub>, we selected, as a reference sample, ZnTe, which is known as a typical terahertz emitter. In the same experimental setup, we measured terahertz radiation from a 0.5-mm-thick (110)-oriented ZnTe crystal. The amplitude of the terahertz electric field of  $\alpha$ -TeO<sub>2</sub> was evaluated to be  $\sim 1/300$  of that of ZnTe. The second-order nonlinear optical coefficient of

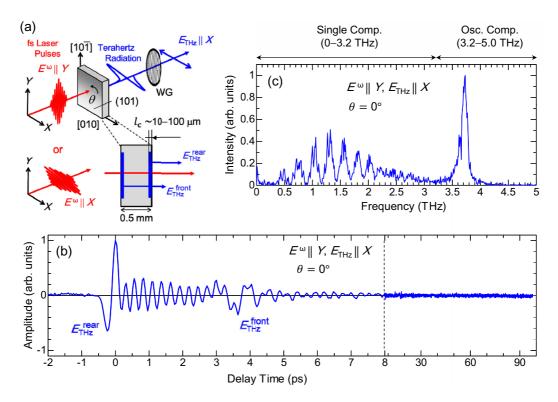


FIG. 5. (Color online) Terahertz radiation from a (101)-oriented single crystal of  $\alpha$ -TeO<sub>2</sub> by the irradiation of a femtosecond laser pulse. (a) Experimental setup for the terahertz radiation. (b) Radiated electromagnetic wave with  $E^{\omega} \parallel Y$  and  $\theta = 0^{\circ}$ . (c) Power spectrum of the measured terahertz wave in (b).

 $\alpha$ -TeO<sub>2</sub> is 0.59 pm/V [24] or 0.69  $\pm$  0.08 pm/V at 1.064  $\mu$ m [25], while that of ZnTe is ~50–120 pm/V [36,37]. Thus, the observed difference of the terahertz electric fields cannot be fully explained by the difference of these values alone. In  $\alpha$ -TeO<sub>2</sub>, there is a difference (~2.2) between *n* in the terahertz frequency region [Fig. 2(c)] and  $n_g$  at 800 nm [Fig. 2(g)]. Thus, the observed difference of the terahertz electric fields can be related to the difference of the coherence length or the effective generation length for the terahertz radiation. The detailed discussion about them is given in Sec. V B.

# D. Azimuth angle and laser power dependence of terahertz radiation

Here we show the results of the azimuth-angle and laserpower dependencies of the terahertz radiation. We measured the waveform from -0.8 ps to 2.7 ps rotating the sample by an angle  $\theta$  around the propagation vector of the femtosecond laser pulse, as illustrated in Fig. 5(a).  $\theta$  was defined as the angle of the [010] direction of the crystal relative to the X axis. The electric field  $E^{\omega}$  of the femtosecond laser pulse was set parallel to the X or Y axis. We detected the X-axis component of the terahertz waves  $(E_{\text{THz}} \parallel X)$ . Figures 6(a) and 6(b) show the  $\theta$ dependence of the terahertz electric fields  $E^{\omega} \parallel Y(E_{\text{THz}}^{XY})$  and  $E^{\omega} \parallel X(E_{\text{THz}}^{XX})$ , respectively. Both quantities were obtained by integrating the amplitude spectrum in the frequency range of 0-3.2 THz, which is characterized by the component of the single-cycle pulse at around 0 ps, as guided by the horizontal arrow in the upper side of Fig. 5(c). They exhibit a notable  $\theta$ dependence. The absolute value of  $E_{\text{THz}}^{XY}$  reaches the maxima at  $\sim 10^{\circ}$  and  $\sim 190^{\circ}$ , while the sign of  $E_{\text{THz}}^{XY}$  is reversed by rotating the sample by  $180^{\circ}$ . On the other hand, the absolute value of  $E_{\text{THz}}^{XX}$  reaches the maxima at  $\sim -50^{\circ}$  and  $\sim 130^{\circ}$  and shows the second maxima at  $\sim 60^{\circ}$  and  $\sim 240^{\circ}$ . We show in Fig. 6(c) the laser power dependence of  $E_{\text{THz}}^{XY}$  (circles) with  $\theta = 0^{\circ}$ ;  $E_{\text{THz}}^{XY}$  linearly increases with the laser power. We discuss the observed  $\theta$  and laser power dependencies of terahertz radiation in Sec. V A in terms of the optical rectification.

Figures 6(d) and 6(e) show the  $\theta$  dependence of  $E_{\text{THz}}^{XY}$ and  $E_{\text{THz}}^{XX}$  of the oscillation component, respectively. Both quantities were obtained by integrating the amplitude spectrum in the frequency range of 3.2–5.0 THz, as indicated by the horizontal arrow in the upper part of Fig. 5(c). Figure 6(f) shows the laser power dependence of  $E_{\text{THz}}^{XY}$  of the oscillation component with  $\theta = 0^{\circ}$ . Observed  $\theta$  and the laser power dependencies are almost the same as those of  $E_{\text{THz}}^{XX}$  and  $E_{\text{THz}}^{XY}$ of the single-cycle terahertz pulse shown in Figs. 6(a)–6(c). We will discuss these results in Sec. V D.

## V. DISCUSSION

#### A. Origin of single-cycle terahertz radiation at 0 ps

Here we explain the observed  $\theta$  and laser power dependencies of the single-cycle terahertz pulse at 0 ps in terms of the optical rectification described in Sec. II.  $\alpha$ -TeO<sub>2</sub> is known to show the birefringence in the transparent frequency region. Indeed, we observed the birefringence (~0.16) at 800 nm, which is characterized by the difference between  $n_0$  and  $n_e$  [see Fig. 2(g)]. Thus, we consider the effect of the birefringence on the nonlinear polarization given by Eq. (2).  $P_{010}$  in Eq. (2) is not influenced by the birefringence because it is generated

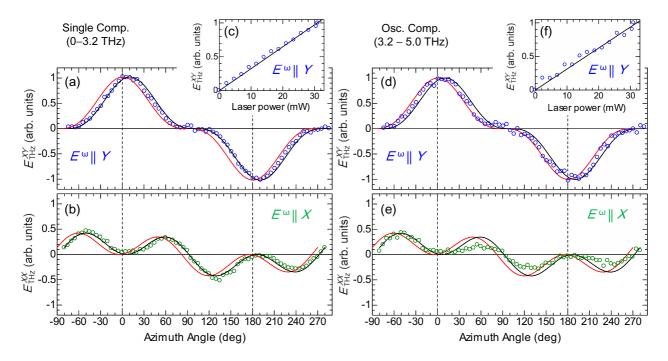


FIG. 6. (Color online) Terahertz radiation characteristics of  $\alpha$ -TeO<sub>2</sub>. Azimuth angle dependence of the terahertz electric field  $E_{\text{THz}}$  (circles) of the single-cycle pulse in (a)  $E^{\omega} \parallel Y (E_{\text{THz}}^{XY})$  and (b)  $E^{\omega} \parallel X (E_{\text{THz}}^{XX})$ .  $E_{\text{THz}}^{XY}$  and  $E_{\text{THz}}^{XX}$  were obtained by integrating the amplitude spectrum in the frequency range of 0–3.2 THz. (c) Laser power dependence of  $E_{\text{THz}}^{YY}$ . Azimuth angle dependence of (d)  $E_{\text{THz}}^{XY}$  and (e)  $E_{\text{THz}}^{XX} E_{\text{THz}}$  (circles) of the temporal oscillation component, which were obtained by integrating the amplitude spectrum in the frequency range of 3.2–5.0 THz. (f) Laser power dependence of  $E_{\text{THz}}^{XY}$ . The red lines represent the calculated curves using Eq. (12) for  $E_{\text{THz}}^{XY}$  and Eq. (10) for  $E_{\text{THz}}^{XX}$ , while the black lines represent the calculated curves including the effect of the optical activity (see text).

by the [101] component of  $E^{\omega}$  alone. On the other hand,  $P_{10\overline{1}}$  is generated by mixing of the [010] and  $[10\overline{1}]$  components of  $E^{\omega}$ , which propagate with different phase velocities because of the birefringence. As a result,  $P_{10\overline{1}}$  changes its phase rapidly with the propagation of a femtosecond laser pulse. This causes the destructive interference of the terahertz waves generated within the crystal. Therefore,  $P_{10\overline{1}}$  in Eq. (2) can be negligible, and the final form of  $P_{NL}^X$  in the  $E^{\omega} \parallel X$  configuration becomes

$$P_{\rm NL}^X = P_{010} = \epsilon_0 d_{14} E_0^2 \sin^2 \theta.$$
 (9)

In our experimental geometry [Fig. 5(a)], we only detected the terahertz electric field  $E_{\text{THz}}$  along the X axis ( $E_{\text{THz}}^{XX}$ ). Therefore,  $E_{\text{THz}}^{XX}$  can be expressed as

$$E_{\rm THz}^{XX} \propto \epsilon_0 d_{14} E_0^2 \sin^2 \theta \cos \theta. \tag{10}$$

In the  $E^{\omega} \parallel Y$ -axis configuration,  $P_{NL}^{Y}$  in Eq. (3) is given by

$$P_{\rm NL}^Y = P_{010} = \epsilon_0 d_{14} E_0^2 \cos^2 \theta.$$
(11)

Accordingly,  $E_{\text{THz}}$  along the Y axis ( $E_{\text{THz}}^{XY}$ ) follows

$$E_{\rm THz}^{XY} \propto \epsilon_0 d_{14} E_0^2 \cos^3 \theta. \tag{12}$$

Using Eq. (12), we calculated  $E_{\text{THz}}^{XY}$  as a function of  $\theta$ , which is indicated by the red line in Fig. 6(a). It shows the maxima at  $\theta = 0^{\circ}$  and its sign is reversed by rotating the sample by 180°. Although the overall trend of the measured  $E_{\text{THz}}^{XY}$  (indicated by open circles) is consistent with the calculated  $E_{\text{THz}}^{XY}$ , the  $\theta$  dependence of the measured  $E_{\text{THz}}^{XY}$  is totally shifted by ~10°. We also calculated  $E_{\text{THz}}^{XX}$  values using Eq. (10) and plotted them in Fig. 6(b). The measured  $E_{\text{THz}}^{XX}$  values [open circles in Fig. 6(b)] also shift by ~10° as compared to the calculated values.

Next we discuss this discrepancy by taking into account the optical activity of  $\alpha$ -TeO<sub>2</sub> at 800 nm.  $\alpha$ -TeO<sub>2</sub> is known to show the optical activity for light propagating along the optic axis [19], in which the polarization of light rotates during the propagation ( $\sim 48.5^{\circ}$ /mm at 800 nm). In our experimental geometry [Fig. 5(a)], the femtosecond laser pulse propagates along the [101] direction, which is inclined by  $45^{\circ}$  from the optic axis. The sample thickness used here was 0.5 mm. Thus, the rotation of the polarization of a femtosecond laser pulse was estimated to be  $\sim 10^{\circ}$  [ $\sim 48.5^{\circ}$ /mm  $\times 0.5$  mm  $\times (\cos 45^{\circ})^2$ ]. Black line in Fig. 6(a) indicates the result of the least-squares fitting of  $E_{\text{THz}}^{XY}$  by taking into account the effect of the rotation of the polarization (~10°). The fitting result well reproduces the  $\theta$  dependence of the measured  $E_{\text{THz}}^{XY}$ . The  $\theta$  dependence of  $E_{\text{THz}}^{XX}$ is also reproduced as indicated by the black line, as shown in Fig. 6(b). From Eq. (12),  $E_{\rm THz}^{XY}$  is expected to increase linearly with the laser power  $(E_0^2)$ . This relation was confirmed for  $E_{\text{THz}}^{XY}$  (circles) with  $\theta = 0^{\circ}$  in Fig. 6(c). From these results, we can conclude that the single-cycle terahertz pulse at 0 ps comes from the optical rectification described by Eqs. (10) and (12).

#### B. Intensity fringe pattern in power spectrum

First, we consider the frequency dependence of the detection sensitivity of terahertz electric fields in our system. We calculated the instrumental function  $I_{inst}$  by considering the response function of the LT-GaAs detector when an ideal terahertz waveform was introduced. As shown in Fig. 7(a),  $I_{inst}$ has a peak structure at ~1.6 THz and extends to ~4.0 THz.

To reveal the origin of the intensity fringe pattern with a period of ~0.25 THz in the power spectrum of terahertz radiation [Fig. 5(c)], we calculated the coherence length  $l_c$  for the terahertz radiation.  $l_c$  is defined as

$$l_{\rm c} = \frac{\lambda_{\rm THz}}{2|n_{\rm g} - n_{\rm o}|},\tag{13}$$

where  $\lambda_{\text{THz}}$  is the terahertz wavelength [38]. In the calculation of  $l_c$ , we used the value of  $n_o$  in the terahertz frequency region, since the electric field of the detected terahertz wave is parallel to the ordinary ray direction, as discussed in Sec. V A [see Eqs. (9) and (11)].  $n_g$  at 800 nm was estimated to be ~2.52 [Fig. 2(g)], which is indicated by the horizontal broken line in Fig. 2(c). The calculated  $l_c$  as a function of frequency is shown in Fig. 7(b). The  $l_c$  spectrum shows the small peak structure at around 3.70 THz, yielding  $l_c \sim 28 \ \mu\text{m}$ . With lowering frequency,  $l_c$  gradually increases and reaches ~140  $\ \mu\text{m}$  at 0.5 THz. Such frequency dependence is due to the decrease of  $n_o$  with lowering frequency and the resultant decrease of the difference between  $n_o$  in the terahertz frequency region and  $n_g$ at 800 nm, as seen in Fig. 2(c).

At 3.66 THz, a strong absorption assigned to the  $E_{TO}$  mode exists [Fig. 2(d)]. To take into account the effect of this absorption, we calculated the effective generation length for the terahertz radiation  $L_{gen}$  (Ref. [39]), which represents the length of the region effectively contributing to the observed terahertz waves. Using the absorption coefficient  $\alpha_0$  shown in Fig. 2(d),  $L_{gen}$  is expressed as

$$L_{\rm gen} = \left[\frac{1 + \exp(-\alpha_{\rm o}d) - 2\exp\left(-\frac{\alpha_{\rm o}}{2}d\right)\cos\left(\frac{\omega}{c}|n_{\rm o} - n_{\rm g}|d\right)}{\left(\frac{\alpha_{\rm o}}{2}\right)^2 + \left(\frac{\omega}{c}\right)^2(n_{\rm o} - n_{\rm g})^2}\right]^{1/2}.$$
(14)

We show in Fig. 7(c) the calculated  $L_{gen}$  as a function of frequency. Because of the presence of the  $E_{TO}$  mode,  $L_{gen}$  is reduced in the wide frequency range down to 0.2 THz;  $L_{gen}$  at around 3.7 THz becomes ~8  $\mu$ m. Furthermore,  $L_{gen}$  oscillates in the frequency region of 0.5–3 THz. The period of this oscillation was estimated to be ~0.25 THz, which is determined by the cosine term of Eq. (14) and is in good agreement with that of the intensity oscillation pattern observed in the power spectrum of the terahertz radiation shown in Fig. 7(e). Thus, we can conclude that the observed intensity fringe pattern originates from the poor phase-matching condition with  $|n_o - n_g| \sim 2.2$  below 3 THz.

Finally, we obtained the frequency dependence of the terahertz radiation efficiency in our system, which was derived from  $I_{inst} \times L_{gen}^2$ , as shown in Fig. 7(d). The estimation procedure of the instrumental function  $I_{inst}$  is detailed in Appendix C. The calculated spectrum of the terahertz radiation efficiency can reproduce well the intensity fringe pattern in the measured power spectrum of the terahertz radiation shown in Fig. 7(e). Although the peak structure at 3.71 THz is observed in Fig. 7(d), its magnitude is much smaller than that of the intensity fringe pattern below 3 THz. This fact indicates that

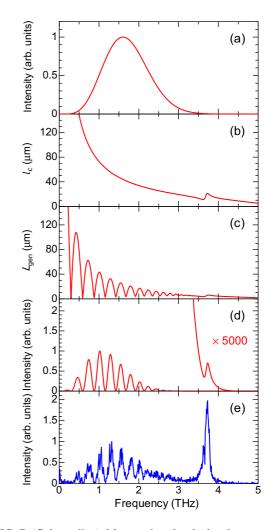


FIG. 7. (Color online) Measured and calculated power spectra of terahertz radiation of  $\alpha$ -TeO<sub>2</sub>. (a) Instrumental function of our experimental setup (see Appendix C). (b) Coherence length  $l_c$  as a function of frequency. (c) Effective generation length  $L_{gen}$  for the terahertz radiation as a function of frequency. (d) Calculated and (e) measured power spectra of terahertz radiation.

another mechanism is necessary to explain the peak structure at 3.71 THz. We will discuss its origin in Sec. V D.

#### C. Second pulse at around 3.5 ps

Here we discuss the reason why the second pulse appears at around 3.5 ps in the waveform [Fig. 5(b)]. A possible reason for the generation of a second pulse is a multiple reflection of the incident femtosecond laser pulse or the radiated terahertz pulse between the sample-air interfaces. In these cases, we can expect the interval ( $\Delta t$ ) between the single-cycle pulse at 0 ps and the second pulse using the relation  $\Delta t = 2n_g d/c$  or  $\Delta t = 2n_o d/c$  and the value of  $n_g$  (~2.52) at 800 nm [Fig. 2(g)] or  $n_o$  (~4.6) below 2 THz [Fig. 2(c)]. Here c and d are the speed of light and the thickness of the sample (0.5 mm), respectively. The values thus expected are  $\Delta t \sim 7.0$  ps and  $\Delta t \sim 15.3$  ps for the multiple reflection of the femtosecond laser pulse and of the radiated terahertz pulse, respectively. The observed interval (~3.5 ps) does not agree with the calculated  $\Delta t$  values. In our experimental condition, the magnitude of  $l_c$  or  $L_{gen}$  is the order of 10–100  $\mu$ m [Figs. 7(c) and 7(b)], which is several times shorter than the thickness of the sample (0.5 mm) used here. In the studies of terahertz radiations from thick LiNbO<sub>3</sub> [40,41], LiTaO<sub>3</sub> [40], and ZnTe [42] single crystals, it was reported that two terahertz pulses can be generated at front and rear surfaces with a poor phase-matching condition. In this case, the interval of two terahertz pulses observed in  $\alpha$ -TeO<sub>2</sub> is expressed as  $\Delta t = |n_o - n_g|d/c$  and equals ~3.5 ps, which agrees well with the observed  $\Delta t$ . Thus, the single-cycle terahertz pulse at around 0 ps and the second pulse at around 3.5 ps can be assigned to terahertz waves generated in the rear and front regions of the crystal, respectively, as illustrated in Fig. 5(a).

#### D. Peak structure at 3.71 THz in the power spectrum

A possible origin of the sharp peak structure at 3.71 THz in the power spectrum of the terahertz radiation is the increase of  $l_{\rm c}$  or  $L_{\rm gen}$  in a narrow frequency region. Increase of  $l_{\rm c}$ or  $L_{\rm gen}$  occurs when the phase-matching condition  $(n_{\rm g} \sim n_{\rm o})$ in Eq. (13) is satisfied. Indeed, the temporal oscillation component in the terahertz wave has been observed near the phonon-polariton resonance in ZnTe [43] and the  $F_2$  phonon mode in Bi<sub>4</sub>Ge<sub>3</sub>O<sub>12</sub> [44]. By taking into account the increase of  $l_c$  or  $L_{gen}$ , we calculated the generation efficiency of the terahertz radiation in  $\alpha$ -TeO<sub>2</sub>, which shows the peak structure at 3.71 THz [Fig. 7(d)]. However, its intensity is more than three orders of magnitude smaller than that below 3 THz. Furthermore, the calculated generation efficiency spectrum cannot reproduce the observed peak structure at 3.71 THz in the power spectrum of the terahertz radiation [Fig. 7(e)]. This clearly rules out the possibility of the phase-matching-induced terahertz radiation at 3.71 THz.

Enhancement of the  $\chi^{(2)}$  near the phonon mode is a candidate for the origin of the peak structure at 3.71 THz. Considering the symmetry of the  $\chi^{(2)}$  tensor given by Eq. (1), the induced  $P_{\rm NL}$  is always parallel to the ordinary ray direction. Thus,  $P_{\rm NL}$  induced by the optical rectification is coupled only with infrared active phonon modes for ordinary ray, i.e., the  $E_{\rm TO}$  mode [31]. Figure 8(a) shows the magnified view of  $\alpha$ spectrum (the green line) [see Fig. 2(d)] and the loss-function  $(-\text{Im}[1/\epsilon])$  spectrum (the red line), which were calculated by using fitting parameters listed in Table III (see Appendix B). We also show in Fig. 8(b) the polarized Raman spectra in the  $x''(z''z'')\overline{x''}$  and  $x'(y'z')\overline{x'}$  configurations, which represent the  $E_{\text{TO}}$  and  $E_{\text{LO}}$  modes, respectively. Within the frequency resolution ( $\sim 2 \text{ cm}^{-1}$ ) indicated by a pair of vertical lines, the peak positions of the  $E_{\rm TO}$  and  $E_{\rm LO}$  modes in the  $\alpha$  spectrum are identical to those in the Raman spectrum, respectively. Apparently, the peak position of the  $E_{\rm TO}$  mode in the  $\alpha$  and Raman spectra differs from the peak position of the power spectrum of the terahertz radiation shown in Fig. 8(c). This clearly excludes the possibility of the enhancement of the  $\chi^{(2)}$ as an origin of the peak structure at 3.71 THz in the power spectrum of the terahertz radiation.

Another possible origin of the 3.71-THz radiation is the coherent phonon generation of the E mode by ISRS [17,45]. To discuss this possibility, we first examine the conservation law of the wave vector dominating the ISRS mechanism. By the irradiation of a femtosecond laser pulse to the sample,

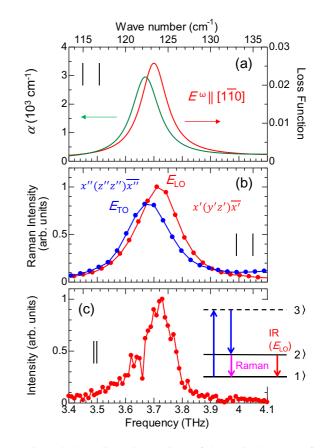


FIG. 8. (Color online) Comparison of the optical spectra of  $\alpha$ -TeO<sub>2</sub> around 3.7 THz with the power spectrum of terahertz radiation. (a) Absorption coefficient  $\alpha$  spectrum (green line) and loss function spectrum (red line). (b) Polarized Raman spectra in the  $x''(z''z'')\overline{x''}$  and  $x'(y'z')\overline{x'}$  configurations, indicated by blue and red circles, respectively. (c) Power spectrum of terahertz radiation. A pair of vertical lines indicates the frequency resolution. Inset of (c) shows the schematic of the energy level.

Raman active modes are coherently excited. By taking into account the conservation law of the wave vector, the coherent phonon should be generated with the wave vector q = 0, i.e., LO mode. As can be seen in Fig. 8(c), the peak position of the power spectrum of terahertz radiation just corresponds to the peak position of the  $E_{\rm LO}$  mode in the  $\alpha$  spectrum [the red line in Fig. 8(a)] and the Raman spectrum in the  $x'(y'z')\overline{x'}$  configuration [the red circles in Fig. 8(b)]. This clearly indicates that terahertz radiation by coherent phonons occurs by the ISRS mechanism.

In ISRS mechanism of terahertz radiation, the related phonon modes are both Raman and infrared active. In the measured window of the terahertz radiation, the  $A_1$ ,  $A_2$ ,  $B_1$ ,  $B_2$ , and E modes exist, as seen in Raman and optical spectra shown in Figs. 3(a)-3(f) and 3(g), respectively. The  $A_1$ ,  $B_1$ , and  $B_2$  modes show no effect on the generation process of the terahertz waves, because infrared-inactive modes cannot be coupled with  $P_{\rm NL}$  [28].  $A_2$  mode has also no contribution to the terahertz radiation, since it is Raman inactive. Thus, only the E mode contributes to the terahertz radiation. Here we discuss the role of the Raman process in terms of the symmetry analysis and explain the observed  $\theta$  dependence of  $E_{\text{TH}_z}^{XY}$  and  $E_{\text{TH}_z}^{XX}$  of the oscillation component, as shown in Figs. 6(d) and 6(e), respectively. We simply consider the three level systems; the ground, middle, and excited levels are denoted as  $|1\rangle$ ,  $|2\rangle$ , and  $|3\rangle$ , respectively, as illustrated in the inset of Fig. 8(c). The matrix element in the process from  $|1\rangle$  to  $|2\rangle$  through  $|3\rangle$  is given by  $M_{jk} = \langle 2|\mu_j|3\rangle \langle 3|\mu_k|1\rangle$ , where  $M_{jk}$  represents the Raman activity of the mode. On the other hand, the matrix element in the process from  $|2\rangle$  to  $|1\rangle$ is represented by  $A_i = \langle 1|\mu_i|2\rangle$ . In the case of the  $E_x$  mode,  $M_{jk}^x$  is given by  $E_x$  in Eq. (4). The dipole moment is polarized along the x axis, thus  $A_i^x = (\beta, 0, 0)$ . In this case, the tensor of  $A_i^x M_{ik}^x$  using the contradicted notation becomes

In the case of the  $E_y$  mode,  $M_{jk}^y$  is given by  $E_y$  in Eq. (4). The dipole moment is polarized along the y axis, thus  $A_i^y = (0, \beta, 0)$ . In this case, the tensor of  $A_i^y M_{jk}^y$  using the contradicted notation becomes

Thus, the tensor of  $A_i^x M_{jk}^x + A_i^y M_{jk}^y$  is given by

$$A_i^x M_{jk}^x + A_i^y M_{jk}^y = \begin{bmatrix} 0 & 0 & 0 & \beta e & 0 & 0 \\ 0 & 0 & 0 & 0 & -\beta e & 0 \\ 0 & 0 & 0 & 0 & 0 & 0 \end{bmatrix}.$$
 (17)

Nonzero tensor components of  $A_i^x M_{ik}^x + A_i^y M_{ik}^y$  are identical to that of  $\chi^{(2)}$  in Eq. (1). Therefore, the  $\theta$  dependence of the terahertz electric field induced by ISRS is the same as that induced by optical rectification, as we observed here [Figs. 6(d) and 6(e)]. This selection rule differs from the well-known selection rule determined by the conventional reflection- or transmission-type pump-and-probe experiments. These experiments measure the change of *n* via the modulation of R and/or T. In this case, the modulation signal should obey the selection rule determined by the Raman tensor. This is because the induced n is proportional to  $R_{ikl}E_k^{\omega}E_l^{\omega}$ , where  $R_{ikl}$ is the Raman tensor [2]. Indeed, it was confirmed that the angle dependence of the modulation signal was the same as that of the Raman tensor in an optically transparent insulator LaAlO<sub>3</sub> [46] and even in an optically opaque GaAs/AlGaAs multiple quantum wells [47]. However, in the terahertz radiation experiments, the modulation of n alone cannot radiate the terahertz wave into free space. Therefore, the  $\theta$  dependence of the terahertz electric field differs from that of the Raman tensor, in contrast to the case of the pump-and-probe experiments [46,47].

#### VI. SUMMARY

In summary, we observed terahertz radiation at room temperature in a noncentrosymmetric and insulating oxide, paratellurite  $\alpha$ -TeO<sub>2</sub>, by the irradiation of a femtosecond laser pulse. The intensity fringe pattern with a period of ~0.25 THz appeared in the power spectrum of the radiated terahertz wave. This intensity fringe pattern was reproduced by taking into account the frequency dependence of the effective generation length for the terahertz radiation with a poor phase-matching condition. Furthermore, we observed a temporal oscillation component in the radiated terahertz wave with a frequency of ~3.71 THz, which just corresponds to the center frequency of the Raman active longitudinal optical *E* mode. On the basis of the comprehensive polarized optical and Raman spectroscopic studies, we concluded that the impulsive stimulated Raman scattering (ISRS) generates the coherent phonon of the longitudinal optical *E* mode, resulting in the emission of the terahertz waves at 3.71 THz.

### ACKNOWLEDGMENTS

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## APPENDIX A: ESTIMATION OF COMPLEX OPTICAL CONSTANTS IN THE TERAHERTZ FREQUENCY REGION BY TERAHERTZ TIME-DOMAIN SPECTROSCOPY

Terahertz time-domain spectroscopy obtains the amplitude and phase spectra by the fast Fourier transformation (FFT) of the measured terahertz waveforms with and without the sample. The black line in Fig. 9 shows the terahertz waveform generated from a (110)-oriented ZnTe crystal, which was used

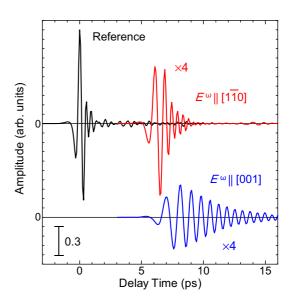


FIG. 9. (Color online) Terahertz waveforms of  $\alpha$ -TeO<sub>2</sub> measured by terahertz time-domain spectroscopy. The reference waveform obtained from a 0.5-mm-thick (110)-oriented ZnTe crystal is shown by the black line. The transmitted terahertz waves passing through the sample in the  $E^{\omega} \parallel [001]$  and  $E^{\omega} \parallel [1\overline{10}]$  configurations are indicated by the blue and red lines, respectively.

as a reference. The transmitted terahertz waveforms passing through the sample in the  $E^{\omega} \parallel [001]$  and  $E^{\omega} \parallel [1\overline{10}]$  configurations are indicated by blue and red lines, respectively. The amplitude of the transmitted terahertz waveforms decreases due to the absorption of the sample. Their phases are also delayed due to the refractive index of the sample. The power transmission *T* and phase  $\phi$  spectra can be obtained by the following relationship:

$$\sqrt{T} \exp(-i\phi) \equiv \frac{E_{\text{sample}}}{E_{\text{reference}}},$$
 (A1)

where  $E_{\text{sample}}$  and  $E_{\text{reference}}$  are FFT spectra with and without the sample, respectively. The obtained T spectra in the  $E^{\omega} \parallel$ [001] and  $E^{\omega} \parallel$  [110] configurations are shown by circles and squares in Fig. 2(b), respectively.

Without taking into account the multiple reflections inside the sample,  $E_{\text{sample}}/E_{\text{reference}}$  in Eq. (A1) is expressed as

$$\frac{E_{\text{sample}}}{E_{\text{reference}}} = \frac{2}{\tilde{n}+1} \frac{2\tilde{n}}{\tilde{n}+1} \exp\left[-i\frac{\omega}{c}d(\tilde{n}-1)\right], \quad (A2)$$

where  $\omega$  is the frequency, *c* is the velocity of light, *d* is the thickness of the sample, and  $\tilde{n}(=n+i\kappa)$  is the complex refractive index of the sample. We avoided the effect of the multiple reflections by restricting the time range of the FFT. We numerically derived the complex optical spectra from Eq. (A2) using experimentally determined *T* and  $\phi$ .

## APPENDIX B: ESTIMATION OF COMPLEX OPTICAL CONSTANTS IN THE TERAHERTZ FREQUENCY REGION BY FOURIER-TRANSFORMED INFRARED SPECTROSCOPY

Figure 10(a) shows the polarized reflectance *R* spectra in the energy range of 7–60 meV, measured by Fourier-transformed infrared (FT-IR) spectroscopy. *R* spectra in the  $E^{\omega} \parallel [001]$  and  $E^{\omega} \parallel [1\overline{10}]$  configurations are shown by circles and squares, respectively. In order to extract complex optical constants in the terahertz frequency region, we performed the dispersion analysis of the measured *R* spectra. Real  $\epsilon_1(\omega)$  and imaginary  $\epsilon_2(\omega)$  parts of the dielectric constant, composed of *N* Lorentz oscillators are, respectively, given by

$$\epsilon_1(\omega) = \epsilon_\infty + \sum_{i=1}^N \left[ \frac{f_i \omega_i^2 (\omega_i^2 - \omega^2)}{(\omega_i^2 - \omega^2)^2 + \gamma_i^2 \omega^2} \right], \quad (B1)$$

$$\epsilon_2(\omega) = \sum_{i=1}^{N} \left[ \frac{f_i \omega_i^2 \gamma_i \omega}{\left(\omega_i^2 - \omega^2\right)^2 + \gamma_i^2 \omega^2} \right], \tag{B2}$$

where  $\epsilon_{\infty}$ ,  $\gamma_i$ ,  $\omega_i$ , and  $f_i$  represent the high-frequency dielectric constant, the damping coefficient, the central frequency, and the oscillator strength, respectively. The measured *R* spectra in the energy range of 7–100 meV were reproduced by the fitting parameters listed in Table III, as indicated by the solid lines in Fig. 10(a). We assumed four and eight Lorentz oscillators in the  $E^{\omega} \parallel [001]$  and  $E^{\omega} \parallel [1\overline{10}]$  configurations, respectively. With the use of the estimated parameters, we calculated the refractive index *n* and absorption coefficient  $\alpha$ spectra for ordinary and extraordinary rays, which are shown in Figs. 10(b) and 10(c), respectively. The peak energies of the observed modes nearly correspond to the peak energies

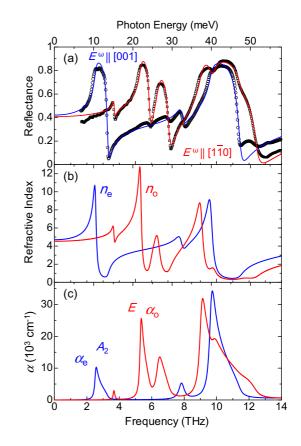


FIG. 10. (Color online) Far-infrared optical spectra of  $\alpha$ -TeO<sub>2</sub> measured by Fourier-transformed infrared (FT-IR) spectroscopy. (a) Reflectance spectra in the  $E^{\omega} \parallel [001]$  and  $E^{\omega} \parallel [1\overline{10}]$  configurations are indicated by circles and squares, respectively. The solid lines are the result of a least-squares fit to the reflectance spectra with parameters listed in Table III. (b) Refractive index *n* and (c) absorption coefficient  $\alpha$  spectra for ordinary and extraordinary rays.

of the modes reported previously (Ref. [31]). According to the mode symmetry, the  $A_2$  modes are infrared active for the extraordinary ray, i.e.,  $E^{\omega} \parallel [001]$ , while the *E* modes are infrared active for the ordinary ray, i.e.,  $E^{\omega} \parallel [1\overline{10}]$ . Thus, the

TABLE III. Obtained fitting parameters of  $\alpha$ -TeO<sub>2</sub> in the  $E^{\omega} \parallel$ [001] configuration with  $\epsilon_{\infty} = 5.38$  and the  $E^{\omega} \parallel$  [110] configuration with  $\epsilon_{\infty} = 5.25$  in the terahertz frequency region.

Representation	Mode <i>i</i>	Configuration	$\omega_i$ (THz)	$\gamma_i \; ({\rm THz})$	$f_i$
$\overline{A_2}$	1	$E^{\omega} \parallel [001]$	2.534	0.150	9.436
	2		7.804	0.375	0.659
	3		9.652	0.306	3.760
	4		18.14	0.685	2.873
Ε	5	$E^{\omega} \parallel [1\overline{1}0]$	3.660	0.111	0.654
	6		5.314	0.155	6.958
	7		6.400	0.361	2.404
	8		9.052	0.310	4.181
	9		9.797	0.495	0.574
	10		11.73	1.064	0.071
	11		18.83	0.561	1.655
	12		22.93	0.498	0.184

observed modes for the ordinary and extraordinary rays can be assigned to the *E* and  $A_2$  modes, respectively. As seen in the magnified *n* and  $\alpha$  spectra shown in Figs. 2(c) and 2(d), the *n* and  $\alpha$  spectra obtained by terahertz time-domain spectroscopy in the transmission geometry are nearly the same as the *n* and  $\alpha$  spectra calculated by use of the procedure described above. This ensures the validity of the present dispersion analysis.

## APPENDIX C: ESTIMATION OF INSTRUMENTAL FUNCTION

We calculated the instrumental function in our experimental setup by considering the response function of the detector when an ideal terahertz wave of optical rectification process was introduced. We used a low-temperature-grown GaAs (LT-GaAs) detector coupled with a dipole antenna. The detector characteristics may be governed by the resonance properties of the antenna structure and by the carrier lifetime [48]. However, it was reported that the response function of the LT-GaAs detector is independent of the resonance character of the antenna [49] and the gap size of the antenna [50]. Thus, we excluded the effect of the antenna structure and simply assumed the response function of the LT-GaAs by taking into account the pulse width of the femtosecond laser pulse and the carrier lifetime of the LT-GaAs. The time profile of the femtosecond laser pulse was ideally given by the following Gaussian intensity envelope:

$$I(t) = I_0 \exp\left(-\frac{2t^2}{\tau^2}\right),\tag{C1}$$

where  $\tau$  is the pulse width of a femtosecond laser pulse used here ( $\tau = 100$  fs). The time profile of the conductivity of the LT-GaAs  $\sigma(t)$  induced by  $\delta$ -function excitation is simply expressed by

$$\sigma(t) = \sigma_0 \exp\left(-\frac{t}{\tau_c}\right) \quad (t > 0),$$
  
= 0 (t \le 0), (C2)

where  $\tau_c$  is the lifetime of the photogenerated carriers. For calculation, we used  $\tau_c = 0.3$  ps, which was estimated by the pump-and-probe reflection measurements reported in Ref. [51]. The calculated  $\sigma(t)$  is shown by the dashed line in Fig. 11(a). The response function of the detector in time domain H(t) can be obtained by convolution of  $\sigma(t)$  and I(t),

$$H(t) = \int_{-\infty}^{\infty} dt' I(t') \sigma(t - t'), \qquad (C3)$$

which is shown by the red line in Fig. 11(a). The amplitude of the response function  $H(\omega)$  is given by

$$H(\omega) = \int_{-\infty}^{\infty} dt \exp(-i\omega t) \int_{-\infty}^{\infty} dt' I(t')\sigma(t-t').$$
 (C4)

We also included the term of  $\omega$  as the terahertz waves spread by diffraction at the detector position. Since we can focus the terahertz waves in the diffraction limited size, the detected amplitude is inversely proportional to the wavelength. Thus, we used  $\omega H(\omega)$  as the detection response function, which is shown by the red line in Fig. 11(b). The phase

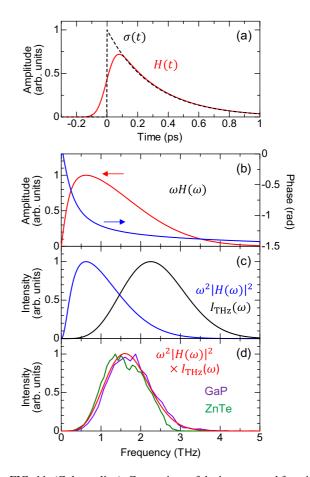


FIG. 11. (Color online) Comparison of the instrumental function in our experimental setup with the power spectra of terahertz radiation in ZnTe and GaP. (a) Response function (red line) of the low-temperature-grown GaAs (LT-GaAs) detector in time domain calculated by Eq. (C3) and the photogenerated conductivity (dashed line) calculated by Eq. (C2). (b) Amplitude of the detection response function  $\omega H(\omega)$  (red line) and the phase of  $\omega H(\omega)$  (blue line). (c) Power spectrum of  $I_{THz}(\omega)$  (black line) and  $I_{res}(\omega)(\propto \omega^2 |H(\omega)|^2)$ (blue line). (d) Red line shows the instrumental function when the ideal terahertz wave was introduced into the LT-GaAs detector. We also show the power spectra of the terahertz radiation emitted from 0.5-mm-thick (110)-oriented ZnTe and 0.2-mm-thick (110)-oriented GaP single crystals, which are shown by the green and purple lines, respectively.

of  $\omega H(\omega)$  is uniquely determined by the condition, i.e.,  $\lim_{\omega \to 0} \arg[H(\omega)] = 0$ , and is plotted by the blue line in Fig. 11(b). Thus, the intensity response function of the LT-GaAs ( $I_{res}$ ) is proportional to  $\omega^2 |H(\omega)|^2$ , which is shown by the blue line in Fig. 11(c).  $I_{res}$  reaches the maxima at  $\sim 0.6$  THz and extends to  $\sim 4$  THz.

We further consider the spectrum of the ideal terahertz wave, which is introduced into the LT-GaAs detector. The ideal terahertz wave is proportional to the second time derivative of the nonlinear polarization  $P_{\rm NL}$ . The induced  $P_{\rm NL}$  would be proportional to the shape of a femtosecond laser pulse. Thus, we simply assumed that the ideal terahertz wave can be represented by the second time derivative of the Gaussian intensity envelope given by Eq. (1). The calculated spectrum of the ideal terahertz wave  $I_{\rm THz}(\omega)$  is shown by the black line in Fig 11(c). It shows the peak structure at ~2.3 THz. Then we obtained the instrumental function  $I_{inst}$  in our experimental setup, which was derived from  $I_{res} \times I_{THz}$ . The red line in Fig. 11(d) shows the calculated  $I_{inst}$ .

To confirm the validity of the calculated  $I_{\text{inst}}$ , we measured the waveform of the terahertz radiation emitted from 0.5-mm-thick (110)-oriented ZnTe and 0.2-mm-thick (110)-oriented GaP crystals in the same experimental setup.  $l_c$  of ZnTe and GaP are the order of  $\sim$ mm [27], exceeding the sample thickness used here. Indeed, the second-order nonlinear

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3 THz [50]. Thus, the spectral shapes of terahertz radiation of ZnTe and GaP are mainly determined by  $I_{inst}$ . We show in Fig. 11(d) the Fourier-transformed spectra of the measured waveforms of ZnTe and GaP, which are indicated by the green and purple lines, respectively. These spectra closely resemble the calculated  $I_{inst}$  indicated by the red line, except for the reduction of the power spectrum of ZnTe above 3 THz. This reduction is due to the presence of the longitudinal acoustic phonon mode at ~3.7 THz with  $\alpha \sim 90$  cm<sup>-1</sup> [52].

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